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## Electrical Characteristics of a High-Temperature Superconducting Coil Insulated with Doped Smart Materials

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V<sub>2</sub>O<sub>3</sub> has been studied as a smart insulation material for 2G high-temperature superconducting (HTS) coils owing to its remarkable metal-to-insulator transition (MIT) upon heating or cooling via a critical temperature ( $T_c$ ) of  $\sim 160$  K. The smart insulated (SI) coil regulates its function according to the MIT properties of V<sub>2</sub>O<sub>3</sub>. At temperatures below  $T_c$ , V<sub>2</sub>O<sub>3</sub> acts as an insulator, whereas it becomes a conductor above  $T_c$ . Under steady-state conditions, the SI coil operates normally as an insulation coil and when quenching causes the coil temperature to rise, the turn-to-turn resistance is lowered, and the current bypasses between the turns as in a no-insulation coil. However, V<sub>2</sub>O<sub>3</sub> has a high critical temperature and low conductivity compared to GdBCO tape, resulting in a small amount of current bypassing the layers of the coil; consequently, this affects the stability and protection of the coil against quenching. Dopants can be incorporated in V<sub>2</sub>O<sub>3</sub> to reduce the critical temperature and improve the electrical conductivity. In this study, we investigated the electrical characteristics of the GdBCO coil, insulated with V<sub>2</sub>O<sub>3</sub> doped with Mo ((V<sub>1-x</sub>Mox)<sub>2</sub>O<sub>3</sub>), by carrying out charging/discharging and overcurrent tests. Additionally, we analyzed the elemental composition and surface morphology of the (V<sub>1-x</sub>Mox)<sub>2</sub>O<sub>3</sub> paste using EDS and SEM, respectively.

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